

Notice of References Cited	Application/Control No. 10/599,532		Applicant(s)/Patent Under Reexamination NAKAMURA ET AL.	
	Examiner J. SanMartin		Art Unit 2837	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,841,626 A	11-1998	Sano et al.	361/321.5
*	B	US-5,935,485 A	08-1999	Tani et al.	252/62.9PZ
*	C	US-6,381,118 B1	04-2002	Yokoyama et al.	361/308.1
*	D	US-2002/0158552 A1	10-2002	Nakamura et al.	310/328
*	E	US-6,930,438 B2	08-2005	Cramer et al.	310/328
*	F	US-7,276,841 B2	10-2007	Takaoka et al.	310/363
*	G	US-7,385,337 B2	06-2008	Mochizuki et al.	310/365
*	H	US-2008/0203857 A1	08-2008	Kastl et al.	310/359
*	I	US-7,439,655 B2	10-2008	Asano et al.	310/328
*	J	US-7,538,475 B2	05-2009	Ohmori et al.	310/328
*	K	US-2001/0043454	11-2001	Yoshii et al.	361/321.2
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	V					
	W					
	X					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.